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- **EPIC™** (Enhanced-Performance Implanted **CMOS) Process**
- Operating Range 2-V to 5.5-V V_{CC}
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- **Package Options Include Plastic** Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

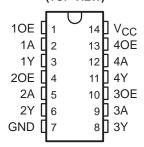
description

The 'AHC126 devices are quadruple bus buffer gates featuring independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable (OE) input is low. When OE is high, the respective gate passes the data from the A input to its Y output.

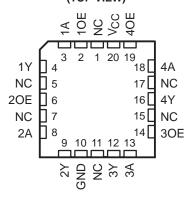
To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

The SN54AHC126 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74AHC126 is characterized for operation from -40°C to 85°C.

SN54AHC126 . . . J OR W PACKAGE SN74AHC126...D, DB, DGV, N, OR PW PACKAGE (TOP VIEW)



SN54AHC126 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE (each buffer)

INP	JTS	OUTPUT
OE	Α	Υ
Н	Н	Н
Н	L	L
L	X	Z



testing of all parameters.

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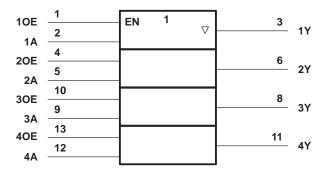
PRODUCTION DATA information is current as of publication date Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include



SN54AHC126, SN74AHC126 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

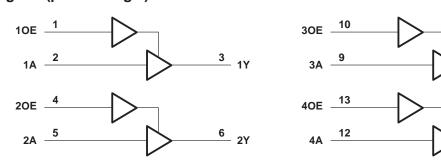
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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

logic diagram (positive logic)



Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}		0.5 V to 7 V
Input voltage range, V _I (see Note 1)		–0.5 V to 7 V
Output voltage range, VO (see Note 1)		$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$)		–20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CO}	c)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$		
Continuous current through V _{CC} or GND		±50 mA
Package thermal impedance, θ_{JA} (see Note 2):		
5,11	DB package	96°C/W
	DGV package	127°C/W
	N package	80°C/W
	PW package	113°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.



recommended operating conditions (see Note 3)

			SN54A	SN54AHC126		HC126	UNIT	
			MIN	MAX	MIN	MAX	UNIT	
Vcc	Supply voltage		2	5.5	2	5.5	V	
		V _{CC} = 2 V	1.5		1.5			
VIH	High-level input voltage	V _{CC} = 3 V	2.1		2.1		V	
		$V_{CC} = 5.5 \text{ V}$	3.85		3.85			
		V _{CC} = 2 V		0.5		0.5		
VIL	IL Low-level input voltage	V _{CC} = 3 V		0.9		0.9	V	
		V _{CC} = 5.5 V		1.65		1.65		
٧ı	Input voltage		0	5.5	0	5.5	V	
٧o	Output voltage		0	VCC	0	VCC	V	
		V _{CC} = 2 V		-50		-50	μΑ	
IOH	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4		-4	mA	
		$V_{CC} = 5 V \pm 0.5 V$		-8		-8	mA	
		V _{CC} = 2 V		50		50	μΑ	
lOL	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4		4	mA	
		$V_{CC} = 5 V \pm 0.5 V$		8		8	IIIA	
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100		100	20/1/	
ΔυΔν	Input transition rise or fall rate	$V_{CC} = 5 V \pm 0.5 V$		20		20	ns/V	
TA	Operating free-air temperature	-	-55	125	-40	85	°C	

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T _A = 25°C			SN54AHC126		SN74AHC126		UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
		2 V	1.9	2		1.9		1.9		
Voн	I _{OH} = -50 μA	3 V	2.9	3		2.9		2.9		
		4.5 V	4.4	4.5		4.4		4.4		V
	I _{OH} = -4 mA	3 V	2.58			2.48		2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		
		2 V			0.1		0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1		0.1	
V _{OL}		4.5 V			0.1		0.1		0.1	V
	I _{OL} = 4 mA	3 V			0.36		0.5		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.5		0.44	
lį	V _I = V _{CC} or GND	0 V to 5.5 V			±0.1		±1*		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.25		±2.5		±2.5	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		40		40	μΑ
C _i	$V_I = V_{CC}$ or GND	5 V		4	10				10	pF

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested at $V_{CC} = 0 \text{ V}$.



SN54AHC126, SN74AHC126 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T	λ = 25°C	;	SN54A	HC126	SN74AI	HC126	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	А	Y	C _I = 15 pF		5.6*	8*	1*	9.5*	1	9.5	ns
t _{PHL}	٨	ı	CL = 13 pr		5.6*	8*	1*	9.5*	1	9.5	115
^t PZH	OE	Y	C _L = 15 pF		5.4*	8*	1*	9.5*	1	9.5	ns
t _{PZL}	OE	ı	GL = 13 pr		5.4*	8*	1*	9.5*	1	9.5	115
tPHZ	05	Y	C 15 pE		7*	9.7*	1*	11.5*	1	11.5	ns
tPLZ	OE	ī	C _L = 15 pF		7*	9.7*	1*	11.5*	1	11.5	115
^t PLH	А	Υ	C _L = 50 pF		8.1	11.5	1	13	1	13	ns
^t PHL	٨	ı	CL = 30 pr		8.1	11.5	1	13	1	13	115
^t PZH	OE	Y	C _I = 50 pF		7.9	11.5	1	13	1	13	ns
t _{PZL}	OE	ı	CL = 30 pr		7.9	11.5	1	13	1	13	115
^t PHZ	OE	Y	C 50 pE		9.5	13.2	1	15	1	15	20
tPLZ]	r	C _L = 50 pF		9.5	13.2	1	15	1	15	ns
tsk(o)			C _L = 50 pF			1.5**				1.5	ns

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	LOAD	T	\ = 25°C	;	SN54AI	HC126	SN74A	HC126	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
tPLH	А	Y	C _I = 15 pF		3.8*	5.5*	1*	6.5*	1	6.5	ns
^t PHL	٨	ı	CL = 13 pr		3.8*	5.5*	1*	6.5*	1	6.5	115
^t PZH	OE	Y	C _L = 15 pF		3.6*	5.1*	1*	6*	1	6	ns
tPZL	OE	,	CL = 13 pr		3.6*	5.1*	1*	6*	1	6	115
^t PHZ	OE	Y	C _I = 15 pF		4.6*	6.8*	1*	8*	1	8	ns
t _{PLZ}	OE	•	CL = 13 pi		4.6*	6.8*	1*	8*	1	8	115
t _{PLH}	А	Y	$C_1 = 50 pF$		5.3	7.5	1	8.5	1	8.5	ns
^t PHL	٨	ı	CL = 30 pr		5.3	7.5	1	8.5	1	8.5	115
^t PZH	OF.	Y	C _L = 50 pF		5.1	7.1	1	8	1	8	ns
t _{PZL}	OE	ı	CL = 30 pr		5.1	7.1	1	8	1	8	115
^t PHZ	OE	Υ	C. = 50 pF		6.1	8.8	1	10	1	10	ns
t _{PLZ}	OL	·	$C_L = 50 \text{ pF}$	·	6.1	8.8	1	10	1	10	115
tsk(o)			C _L = 50 pF			1**				1	ns

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



^{**} On products compliant to MIL-PRF-38535, this parameter does not apply.

^{**} On products compliant to MIL-PRF-38535, this parameter does not apply.

noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C (see Note 4)

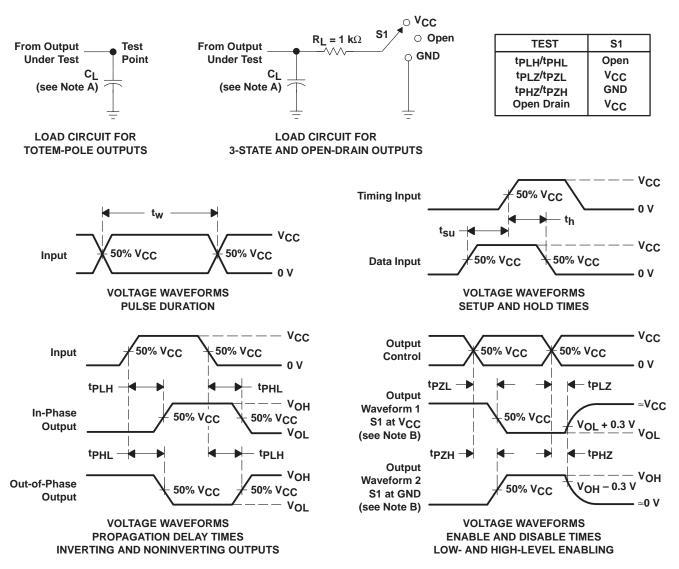
	PARAMETER		SN74AHC126		
	FARAMETER	MIN	MAX	UNIT	
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.8	V	
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.8	V	
VOH(V)	Quiet output, minimum dynamic V _{OH}	4.4		V	
VIH(D)	High-level dynamic input voltage	3.5		V	
V _{IL(D)}	Low-level dynamic input voltage		1.5	V	

NOTE 4: Characteristics are for surface-mount packages only.

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load, f = 1 MHz	14	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f \leq 3 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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